

**IGBT** 

TRENCHSTOP<sup>™</sup> IGBT4 Low Power Chip IGC11T120T8L

**Data Sheet** 

Industrial Power Control

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### TRENCHSTOP<sup>™</sup> IGBT4 Low Power Chip

#### Features:

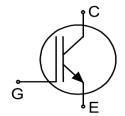
- 1200V trench & field stop technology
- Low switching losses
- Positive temperature coefficient
- Easy paralleling

#### Recommended for:

Low / medium power modules

#### **Applications:**

• Low / medium power drives



Chip Type	<b>V</b> <sub>CE</sub>	<b>/</b> Cn <sup>1</sup>	Die Size	Package
IGC11T120T8L	1200V	8A	3.48mm x 3.19mm	Sawn on foil

#### **Mechanical Parameters**

Die size		3.48 x 3.19		
Emitter pad size		See chip drawing	mm²	
Gate pad size		0.608 x 0.608	- mm	
Area total 11.1		11.1		
Thickness		115	μm	
Wafer size		200	mm	
Maximum possible ch	ips per wafer	2408		
Passivation frontside		Photoimide		
Pad metal		3200nm AlSiCu		
Backside metal rec		Ni Ag – system  To achieve a reliable solder connection it is strongly recommended not to consume the Ni layer completely during production process		
Die bond		Electrically conductive epoxy glue and soft solder		
Wire bond		AI, ≤500μm		
Reject ink dot size		Ø 0.65mm; max. 1.2mm		
Ctorage environment	for original and sealed MBB bags	Ambient atmosphere air, temperature 17°C – 25 <6 months		
Storage environment	for open MBB bags	Acc. to IEC62258-3: atmosphere >99% Nitrogen or inert ghumidity <25%RH, temperature 17°C – 25°C, <6 month		

<sup>&</sup>lt;sup>1</sup> Nominal collector current at TC = 100°C assuming chip assembly in TO-247 package.

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#### **Maximum Ratings**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>vj</sub> =25°C	V <sub>CE</sub>	1200	V
DC collector current, limited by $T_{\rm vj\;max}^{\;\;2}$	I <sub>C</sub>	-	А
Pulsed collector current, $t_p$ limited by $T_{vj \max}$ 3	I <sub>C,puls</sub>	24	Α
Gate-emitter voltage	$V_{GE}$	±20	V
Operating junction temperature	$T_{vj}$	-40 +175	°C
Short circuit data $^{3/4}$ $V_{GE}$ =15V, $V_{CC}$ =800V, $T_{vj}$ =150°C	t <sub>sc</sub>	10	μs

#### Static Characteristics (tested on wafer), T<sub>vi</sub>=25°C

Parameter	Cumbal	Conditions	Value			Unit	
rarameter	Symbol	Conditions		typ.	max.		
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{\text{GE}}$ =0V, $I_{\text{C}}$ =0.5mA	1200	-	-		
Collector-emitter saturation voltage	V <sub>CEsat</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =8A	1.58	1.85	2.07	V	
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =0.15mA, $V_{\rm GE}$ = $V_{\rm CE}$	5.3	5.8	6.3		
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V, V <sub>GE</sub> =0V	-	-	1	μA	
Gate-emitter leakage current	I <sub>GES</sub>	$V_{\text{CE}}$ =0V, $V_{\text{GE}}$ =20V	-	-	120	nA	
Integrated gate resistor	r <sub>G</sub>			none		Ω	

#### **Electrical Characteristics** <sup>3</sup>

Parameter	Symbol	Conditions	Value			Unit
raiailietei			min.	typ.	max.	Onit
Collector-emitter saturation voltage	V <sub>CEsat</sub>	$V_{\text{GE}} = 15 \text{V}, I_{\text{C}} = 8 \text{A}, \ T_{\text{vj}} = 150 ^{\circ} \text{C}$	-	2.25	-	V
Input capacitance	C <sub>ies</sub>	V <sub>CE</sub> =25V,	-	490	-	nE
Reverse transfer capacitance	C <sub>res</sub>	$V_{\text{GE}}$ =0V, $f$ =1MHz $T_{\text{vj}}$ =25°C	-	30	-	pF

<sup>&</sup>lt;sup>2</sup> Depending on thermal properties of assembly.

<sup>&</sup>lt;sup>3</sup> Not subject to production test - verified by design/characterization.

<sup>&</sup>lt;sup>4</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.



#### **Further Electrical Characteristics**

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

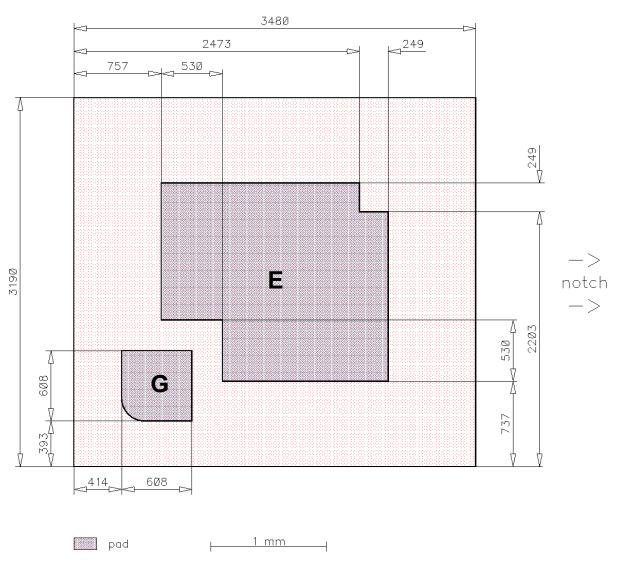
Application example	-	_	
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#### **Chip Drawing**





**E** = Emitter

**G** = Gate



#### **Bare Die Product Specifics**

Test coverage at wafer level cannot cover all application conditions. Therefore it is recommended to test all characteristics which are relevant for the application at package level, including RBSOA and SCSOA.

#### **Description**

AQL 0.65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

#### **Revision History**

Revision	Subjects (major changes since last revision)	Date
2.0	Final data sheet	18.02.2015
2.1	Update disclaimer	20.08.2015

# Relevant Application Notes



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